Search Notes



Applicant(s)/Patent under Reexamination BAXTER ET AL

10/824,713

Examiner

Christopher B. Shin

2181

Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
710	22-28, 308-310	9/25/2006	cs	
711	208	9/25/2006	cs	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
710	22,33,308	3/9/2007	cs	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS	9/25/2006	cs		
PALM	9/25/2006	cs		
EAST (uspgpub, uspat, usocr, epo, jpo, derwent, ibmtdb)	9/25/2006	cs		